

UNITED STATES PATENT AND TRADEMARK OFFICE

UNITED STATES DEPARTMENT OF COMMERCE
United States Patent and Trademark Office
Address: COMMISSIONER OF PATENTS AND TRADEMARKS
Washington, D.C. 20231
www.uspto.gov

APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.	
09/844,080	04/26/2001	Philippe J. Goix	A-69516/AJT	9621	
7:	590 10/21/2002				
Aldo J. Test FLEHR HOHBACH TEST ALBRITTON & HERBERT LLP Four Embarcadero Center, Suite 3400			EXAMI	EXAMINER	
			GABEL, GAILENE		
San Francisco,	CA 94111-4187		ART UNIT	PAPER NUMBER	
			1641		
			DATE MAILED: 10/21/2002	X	

Please find below and/or attached an Office communication concerning this application or proceeding.

•	Application No.	Applicant(s)	
	09/844,080	GOIX ET AL.	
Office Action Summary	Examiner	Art Unit	
	Gailene R. Gabel	1641	
The MAILING DATE of this communication app Period for Reply	ears on the cover sheet wi	th the c rrespondence addre	SS
A SHORTENED STATUTORY PERIOD FOR REPLY THE MAILING DATE OF THIS COMMUNICATION. - Extensions of time may be available under the provisions of 37 CFR 1.13 after SIX (6) MONTHS from the mailing date of this communication. - If the period for reply specified above is less than thirty (30) days, a reply - If NO period for reply is specified above, the maximum statutory period w - Failure to reply within the set or extended period for reply will, by statute, - Any reply received by the Office later than three months after the mailing earned patent term adjustment. See 37 CFR 1.704(b). Status	36(a). In no event, however, may a re within the statutory minimum of thirty iill apply and will expire SIX (6) MON cause the application to become AB	eply be timely filed (30) days will be considered timely. THS from the mailing date of this comm ANDONED (35 U.S.C. § 133).	unication.
1) Responsive to communication(s) filed on <u>05 A</u>	ugust 2002 .		
2a) This action is FINAL . 2b) This	is action is non-final.		
3) Since this application is in condition for alloward closed in accordance with the practice under a Disposition of Claims			nerits is
4) ☐ Claim(s) <u>1-33</u> is/are pending in the application			
4a) Of the above claim(s) is/are withdraw			
5) Claim(s) is/are allowed.			
6) Claim(s) is/are rejected.			
7) Claim(s) is/are objected to.			
8) Claim(s) 1-33 are subject to restriction and/or e	election requirement.		
Application Papers			
9)☐ The specification is objected to by the Examine	·.		
10)☐ The drawing(s) filed on is/are: a)☐ accept	eted or b) objected to by the	ne Examiner.	
Applicant may not request that any objection to the			
11)☐ The proposed drawing correction filed on		sapproved by the Examiner.	
If approved, corrected drawings are required in rep			
12) The oath or declaration is objected to by the Exa	aminer.		
Priority under 35 U.S.C. §§ 119 and 120		. 440() () ()	
13) Acknowledgment is made of a claim for foreign	priority under 35 U.S.C. §	119(a)-(d) or (t).	
a) All b) Some * c) None of:			
Certified copies of the priority documents			
2. Certified copies of the priority documents			
 3. Copies of the certified copies of the prior application from the International But * See the attached detailed Office action for a list 	reau (PCT Rule 17.2(a)).		ıge
14) Acknowledgment is made of a claim for domestic	c priority under 35 U.S.C.	§ 119(e) (to a provisional ap	plication).
 a) The translation of the foreign language pro 15) Acknowledgment is made of a claim for domesting 			
Attachment(s)			
1) Notice of References Cited (PTO-892) 2) Notice of Draftsperson's Patent Drawing Review (PTO-948) 3) Information Disclosure Statement(s) (PTO-1449) Paper No(s)	5) Notice of I	Summary (PTO-413) Paper No(s). nformal Patent Application (PTO-1	

Art Unit: 1641

DETAILED ACTION

Election/Restrictions

- 1. Restriction to one of the following inventions is required under 35 U.S.C. 121:
 - I. Claims 1-11, drawn to a particle analyzing apparatus having at least one fluorescent light detector, classified in class 422, subclass 68.1, for example.
 - II. Claims 12-19, drawn to a particle analyzing apparatus having multiple detectors for detecting particles at multiple wavelengths, classified in class 422, subclass 68.1, for example.
 - III. Claims 20-25, drawn to a particle analyzing apparatus having a capillary tube with selected internal cross-section diameter for singulate particle flow, classified in class 422, subclass 68.1, for example.
 - IV. Claims 26-28, drawn to a method of detecting tagged particles, classified in class 435, subclass 287.1.
 - V. Claims 29-33, drawn to a particle analyzing apparatus having a detector which includes a fiber optic waveguide, classified in class 422, subclass 68.1, for example.
- 2. The inventions are distinct, each from the other because of the following reasons:

 Inventions I, II, III, and V are related as subcombinations disclosed as usable together in a single combination. The subcombinations are distinct from each other if

Art Unit: 1641

they are shown to be separately usable. In the instant case, invention I has separate utility such as for determining viability of cells labeled for a particular cellular activity, Invention II has separate utility such as for determining protein secreted from cells which are trapped into gel-microdrops at different wavelengths, invention III has separate utility such as for sorting cell populations having predetermined cell sizes, and Invention V has separate utility such as for determining kinetic activity of cell surface-bound receptors. See MPEP § 806.05(d).

Inventions I, II, III, V and Invention IV are related as process and apparatus for its practice. The inventions are distinct if it can be shown that either: (1) the process as claimed can be practiced by another materially different apparatus or by hand, or (2) the apparatus as claimed can be used to practice another and materially different process. (MPEP § 806.05(e)). In this case, the process as claimed in Invention IV can be performed using an optical trapping or tweezing device.

Because these inventions are distinct for the reasons given above and have acquired a separate status in the art as shown by their different classification, restriction for examination purposes as indicated is proper. Furthermore, because the search required for Group I is not require for Group II and the search required for Group III is not required for Group IV and further not required for Group V, restriction for examination purposes as indicated is proper. Literature search for each method and apparatus is distinct since the structural requirements of each invention are different. While searches would be expected to overlap, there is no reason to expect the searches to be coextensive.

Art Unit: 1641

3. Applicant is advised that the reply to this requirement to be complete must include an election of the invention to be examined even though the requirement be traversed (37 CFR 1.143).

Applicant is reminded that upon the cancellation of claims to a non-elected invention, the inventorship must be amended in compliance with 37 CFR 1.48(b) if one or more of the currently named inventors is no longer an inventor of at least one claim remaining in the application. Any amendment of inventorship must be accompanied by a request under 37 CFR 1.48(b) and by the fee required under 37 CFR 1.17(i).

4. Any inquiry concerning this communication or earlier communications from the examiner should be directed to Gailene R. Gabel whose telephone number is (703) 305-0807. The examiner can normally be reached on Monday to Thursday, 6:30 AM - 4:00 PM and alternate Fridays.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Long V. Le can be reached on (703) 308-3399. The fax phone numbers for the organization where this application or proceeding is assigned are (703) 308-4242 for regular communications and (703) 308-4242 for After Final communications.

Any inquiry of a general nature or relating to the status of this application or proceeding should be directed to the receptionist whose telephone number is (703) 308-0196.

Art Unit: 1641

Gailene R. Gabel October 17, 2002

> CHRISTOPHER L. CHIN PRIMARY EXAMINER GROUP 1800-7647

Christyl L. Chin